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Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (\_), the underscore (\_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (\_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <a href="mailto:www.onsemi.com">www.onsemi.com</a>. Please email any questions regarding the system integration to <a href="mailto:Fairchild\_questions@onsemi.com">Fairchild\_questions@onsemi.com</a>.

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	28878 Annel Power Trenc	h <sup>®</sup> MC	DSFET		Nover	nber 20
30V, 16. Feature	<b>5Α, 14m</b> Ω s		General	Descrintio	n	
• Max $r_{DS(on)} = 14m\Omega$ at $V_{GS} = 10V$ , $I_D = 9.6A$ • Max $r_{DS(on)} = 17m\Omega$ at $V_{GS} = 4.5V$ , $I_D = 8.7A$ • Low Profile - 0.8 mm max in MLP 3.3X3.3		General Description This N-Channel MOSFET is a rugged gate version Fairchild Semiconductor's advanced Power Trend process. It has been optimized for power manageme applications.				
■ RoHS Compliant			Application ■ DC - DC Conversion			
	Тор В	ottom				
	8 7 6 5 D	ррр				
				D 6		3 S
1		S S Pin 1	1	D 6 D 7 D 8		3 S 2 S 1 S
1	2 3 4 G S S MLP 3.3x3.3	S S <sub>Pin 1</sub>	1	D 7		2 S
10SFE	MLP 3.3x3.3 T Maximum Ratings Τ <sub>Α</sub> = 25°C	C unless othe		D 7	Patings	2 S 1 S
IOSFE <sup>-</sup> Symbol	MLP 3.3x3.3 T Maximum Ratings т <sub>А</sub> = 25°С Раг			D 7	Ratings 30	2 S 1 S
NOSFE Symbol	MLP 3.3x3.3 T Maximum Ratings Τ <sub>Α</sub> = 25°C	C unless othe		D 7	•	2 S 1 S
NOSFE Symbol	MLP 3.3x3.3 T Maximum Ratings T <sub>A</sub> = 25°C Par Drain to Source Voltage Gate to Source Voltage Drain Current -Continuous (Package	C unless othe rameter	erwise noted T <sub>C</sub> = 25°C	D 7	30	2 S 1 S
AOSFE Symbol /DS /GS	MLP 3.3x3.3 T Maximum Ratings T <sub>A</sub> = 25°C Par Drain to Source Voltage Gate to Source Voltage Drain Current -Continuous (Package -Continuous (Silicon li	C unless othe rameter	erwise noted $T_{C} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$	D 7 D 8	30 ±20 16.5 38	2 S 1 S Unit
AOSFE Symbol /DS /GS	MLP 3.3x3.3 T Maximum Ratings T <sub>A</sub> = 25°C Par Drain to Source Voltage Gate to Source Voltage Drain Current -Continuous (Package -Continuous (Silicon li -Continuous	C unless othe rameter	erwise noted T <sub>C</sub> = 25°C	D 7	30 ±20 16.5 38 9.6	2 S 1 S
AOSFE Symbol /DS /GS	MLP 3.3x3.3 T Maximum Ratings T <sub>A</sub> = 25°C Par Drain to Source Voltage Gate to Source Voltage Drain Current -Continuous (Package -Continuous (Silicon li -Continuous -Pulsed	C unless othe rameter	T <sub>C</sub> = 25°C T <sub>C</sub> = 25°C T <sub>C</sub> = 25°C T <sub>A</sub> = 25°C	D 7	30 ±20 16.5 38 9.6 60	2 S 1 S Unit: V
MOSFE Symbol / <sub>DS</sub> / <sub>GS</sub>	MLP 3.3x3.3 T Maximum Ratings T <sub>A</sub> = 25°C Par Drain to Source Voltage Gate to Source Voltage Drain Current -Continuous (Package -Continuous (Silicon li -Continuous -Pulsed Power Dissipation	C unless othe rameter	T <sub>C</sub> = 25°C T <sub>C</sub> = 25°C T <sub>A</sub> = 25°C T <sub>C</sub> = 25°C T <sub>C</sub> = 25°C	D 7 D 8 (Note 1a)	30 ±20 16.5 38 9.6 60 31	2 S 1 S Unit: V
MOSFE Symbol /DS /GS D	MLP 3.3x3.3 T Maximum Ratings T <sub>A</sub> = 25°C Par Drain to Source Voltage Gate to Source Voltage Drain Current -Continuous (Package -Continuous (Silicon li -Continuous Pulsed Power Dissipation Power Dissipation	c unless othe rameter e limited) mited)	erwise noted $T_{C} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C$	D 7	30 ±20 16.5 38 9.6 60 31 2.1	2 S 1 S 1 S
AOSFE Symbol /os /os D Po	MLP 3.3x3.3 T Maximum Ratings T <sub>A</sub> = 25°C Par Drain to Source Voltage Gate to Source Voltage Drain Current -Continuous (Package -Continuous (Silicon li -Continuous -Pulsed Power Dissipation Power Dissipation Power Dissipation Operating and Storage Junction Tem	c unless othe rameter e limited) mited)	erwise noted $T_{C} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C$	D 7 D 8 (Note 1a)	30 ±20 16.5 38 9.6 60 31	2 S 1 S 1 S
MOSFE Symbol V <sub>DS</sub> V <sub>GS</sub> ID P <sub>D</sub> TJ, T <sub>STG</sub>	MLP 3.3x3.3 T Maximum Ratings T <sub>A</sub> = 25°C Par Drain to Source Voltage Gate to Source Voltage Drain Current -Continuous (Package -Continuous (Silicon li -Continuous Pulsed Power Dissipation Power Dissipation	C unless othe rameter e limited) mited) perature Rar	erwise noted $T_{C} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C$	D 7 D 8 (Note 1a)	30 ±20 16.5 38 9.6 60 31 2.1	2 S 1 S V V A W

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC8878	FDMC8878	MLP 3.3X3.3	13 "	12 mm	3000 units

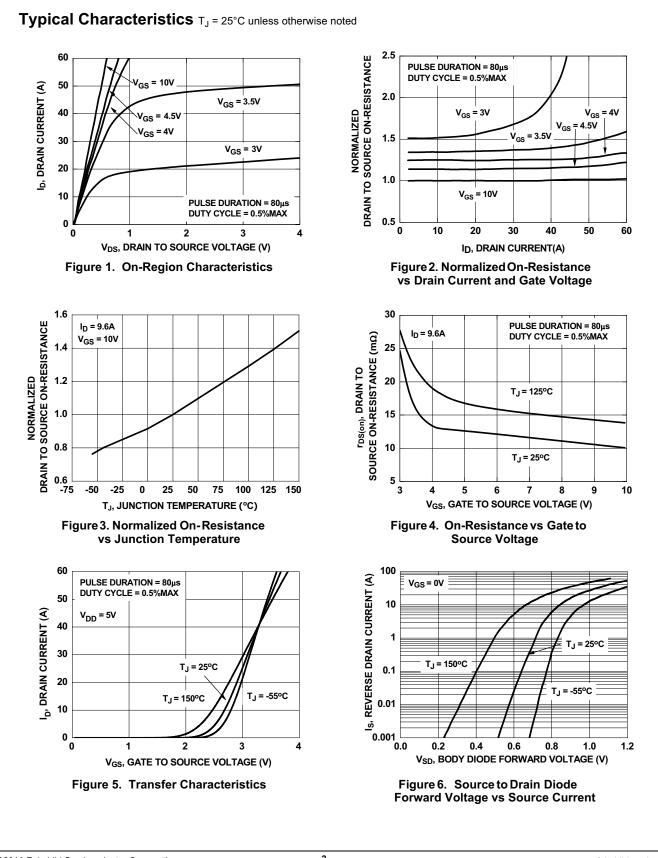
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FDMC8878
N-Channel
Power
Trench®
MOSFET

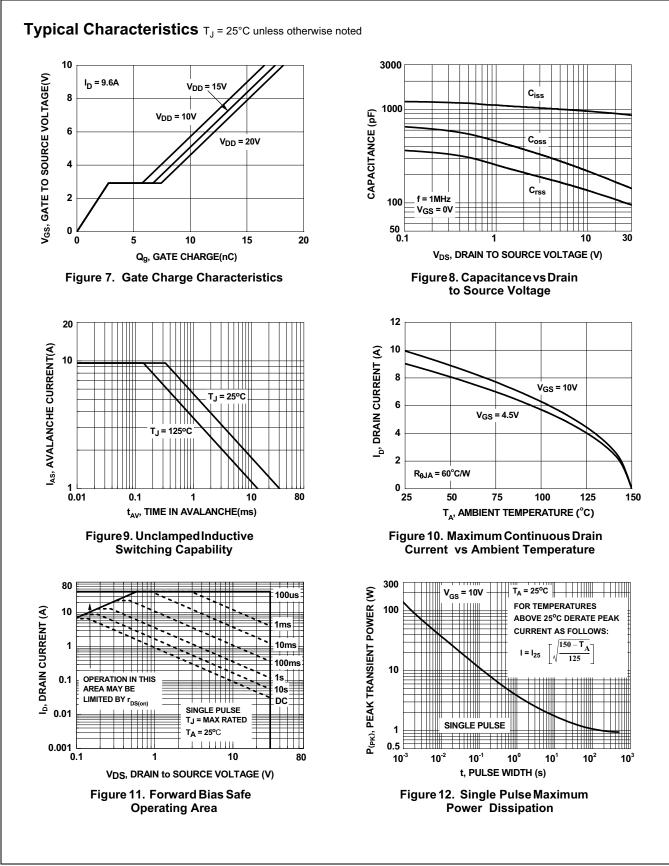
ics p Source Breakdown Voltage own Voltage Temperature ient ate Voltage Drain Current p Source Leakage Current ics p Source Threshold Voltage p Source Threshold Voltage rature Coefficient	$I_{D} = 250\mu A, V_{GS} = 0V$ $I_{D} = 250\mu A, referenced to 25°C$ $V_{DS} = 24V,$ $V_{GS} = 0V$ $T_{J} = 125°C$ $V_{GS} = \pm 20V, V_{DS} = 0V$ $V_{GS} = V_{DS}, I_{D} = 250\mu A$ $I_{D} = 250\mu A, referenced to 25°C$	30	20 20 1.7	1 100 ±100	V mV/°C μA nA
own Voltage Temperature ient ate Voltage Drain Current o Source Leakage Current ics o Source Threshold Voltage o Source Threshold Voltage	$I_{D} = 250\mu\text{A}, \text{ referenced to } 25^{\circ}\text{C}$ $V_{DS} = 24\text{V},$ $V_{GS} = 0\text{V} \qquad T_{J} = 125^{\circ}\text{C}$ $V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = V_{DS}, I_{D} = 250\mu\text{A}$			100 ±100	mV/°C μA nA
own Voltage Temperature ient ate Voltage Drain Current o Source Leakage Current ics o Source Threshold Voltage o Source Threshold Voltage	$I_{D} = 250\mu\text{A}, \text{ referenced to } 25^{\circ}\text{C}$ $V_{DS} = 24\text{V},$ $V_{GS} = 0\text{V} \qquad T_{J} = 125^{\circ}\text{C}$ $V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = V_{DS}, I_{D} = 250\mu\text{A}$	1		100 ±100	μA nA
o Source Leakage Current ics o Source Threshold Voltage o Source Threshold Voltage	$V_{GS} = 0V$ $T_{J} = 125^{\circ}C$ $V_{GS} = \pm 20V, V_{DS} = 0V$ $V_{GS} = V_{DS}, I_{D} = 250\mu A$	1	1.7	100 ±100	nA
o Source Leakage Current ics o Source Threshold Voltage o Source Threshold Voltage	$V_{GS} = \pm 20V, V_{DS} = 0V$ $V_{GS} = V_{DS}, I_D = 250\mu A$	1	1.7	±100	nA
ics Source Threshold Voltage Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250μA	1	1.7	1	I
Source Threshold Voltage Source Threshold Voltage		1	1.7	3	
Source Threshold Voltage		1	1.7	3	
•	$I_{-} = 250 \mu A$ referenced to $25^{\circ}C$			Ŭ	V
	$T_D = 200 \mu A$ , referenced to 20 G		-5.7		mV/°C
Drain to Source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 9.6A		9.6	14.0	
	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 8.7A		12.1	17.0	mΩ
	$V_{GS}$ = 10V, I <sub>D</sub> = 9.6A , T <sub>J</sub> = 125°C		13.5	20.0	
1 Transconductance	V <sub>DS</sub> = 5V, I <sub>D</sub> = 9.6A		35		S
cteristics					
apacitance			1000	1230	pF
Capacitance			183	255	pF
e Transfer Capacitance	f = 1MHz		118	180	pF
esistance	f = 1MHz		1.1		Ω
me ff Delay Time	<sup>—</sup> V <sub>DD</sub> = 15V, I <sub>D</sub> = 9.6A — V <sub>GS</sub> = 10V, R <sub>GEN</sub> = 6Ω		4 20	10 36	ns ns ns
			-		ns
	$V_{} = 10V_{} = 15V_{}$		18	26	nC
-			-		nC
Drain "Miller" Charge			3.9		nC
ode Characteristics					
	$V_{cc} = 0V_{cc} = 9.6A_{cc}$ (Note 2)		0.8	1.2	V
•			23	35	ns
e Recovery Charge	— I <sub>F</sub> = 9.6A, di/dt = 100A/μs		14	21	nC
	eteristics apacitance Capacitance e Transfer Capacitance esistance acteristics n Delay Time me ff Delay Time ne ate Charge Source Gate Charge Drain "Miller" Charge ode Characteristics to Drain Diode Forward Voltage e Recovery Time e Recovery Charge	I Transconductance $V_{DS} = 5V, I_D = 9.6A$ eteristics         apacitance $V_{DS} = 15V, V_{GS} = 0V, f = 1MHz$ e Transfer Capacitance $f = 1MHz$ e Transfer Capacitance $f = 1MHz$ esistance $f = 1MHz$ etteristics $f = 1MHz$ n Delay Time $V_{DD} = 15V, I_D = 9.6A$ me $V_{DD} = 15V, I_D = 9.6A$ ff Delay Time $V_{GS} = 10V, N_{GEN} = 6\Omega$ ne $I_D = 9.6A$ Source Gate Charge $V_{GS} = 10V, V_{DD} = 15V, I_D = 9.6A$ Drain "Miller" Charge $V_{GS} = 0V, I_S = 9.6A$ (Note 2)         e Recovery Time $I_F = 9.6A, di/dt = 100A/\mu s$	I Transconductance $V_{DS} = 5V$ , $I_D = 9.6A$ eteristics         apacitance $V_{DS} = 15V$ , $V_{GS} = 0V$ , f = 1MHz         e Transfer Capacitance       f = 1MHz         e sistance       f = 1MHz         eteristics       f = 1MHz         n Delay Time $V_{DD} = 15V$ , $I_D = 9.6A$ me $V_{DD} = 15V$ , $I_D = 9.6A$ ff Delay Time $V_{GS} = 10V$ , $R_{GEN} = 6\Omega$ ne $I_D = 9.6A$ Source Gate Charge $I_D = 9.6A$ Drain "Miller" Charge $V_{GS} = 0V$ , $I_S = 9.6A$ (Note 2)         e Recovery Time $I_F = 9.6A$ , di/dt = 100A/µs	I Transconductance $V_{DS} = 5V$ , $I_D = 9.6A$ 35atteristicsapacitance $V_{DS} = 15V$ , $V_{GS} = 0V$ , f = 1MHz1000Capacitancef = 1MHz118e Transfer Capacitancef = 1MHz1.1esistancef = 1MHz1.1incteristics $V_{DD} = 15V$ , $I_D = 9.6A$ 8me $V_{DD} = 15V$ , $I_D = 9.6A$ 4Me $V_{GS} = 10V$ , $R_{GEN} = 6\Omega$ 20ineate Charge $V_{GS} = 10V$ , $V_{DD} = 15V$ , $I_D = 9.6A$ 18Source Gate Charge $V_{GS} = 10V$ , $V_{DD} = 15V$ , $I_D = 9.6A$ 3.9ode Characteristics3.93.9ode Characteristics $V_{GS} = 0V$ , $I_S = 9.6A$ (Note 2)0.8e Recovery Time e Recovery Charge $I_F = 9.6A$ , di/dt = 100A/µs14	I Transconductance $V_{DS} = 5V$ , $I_D = 9.6A$ 35         eteristics       apacitance $V_{DS} = 15V$ , $V_{GS} = 0V$ , f = 1MHz       1000       1230         Capacitance       f = 1MHz       183       255         e Transfer Capacitance       f = 1MHz       118       180         esistance       f = 1MHz       1.1       118       180         esistance       f = 1MHz       1.1       111       111         incteristics       V_{DD} = 15V, $I_D = 9.6A$ 8       16         me $V_{DD} = 15V, R_{GEN} = 6\Omega$ 20       36         in Delay Time       V_{GS} = 10V, R_{GEN} = 6\Omega       20       36         in Delay Time       V_{GS} = 10V, V_{DD} = 15V, $I_D = 9.6A$ 4       10         in Delay Time       V_{GS} = 10V, V_{DD} = 15V, $I_D = 9.6A$ 2.8       2.8         in Date Charge       V_{GS} = 10V, V_{DD} = 15V, $I_D = 9.6A$ 2.8       2.8         in Drain "Miller" Charge       3.9       3.9       3.9         ode Characteristics       3.9       3.9       3.9       3.9         in Drain Diode Forward Voltage       V_{GS} = 0V, I_S = 9.6A       0.04(dt = 100A/us)       2.3       3.5

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FDMC8878 N-Channel Power Trench<sup>®</sup> MOSFET



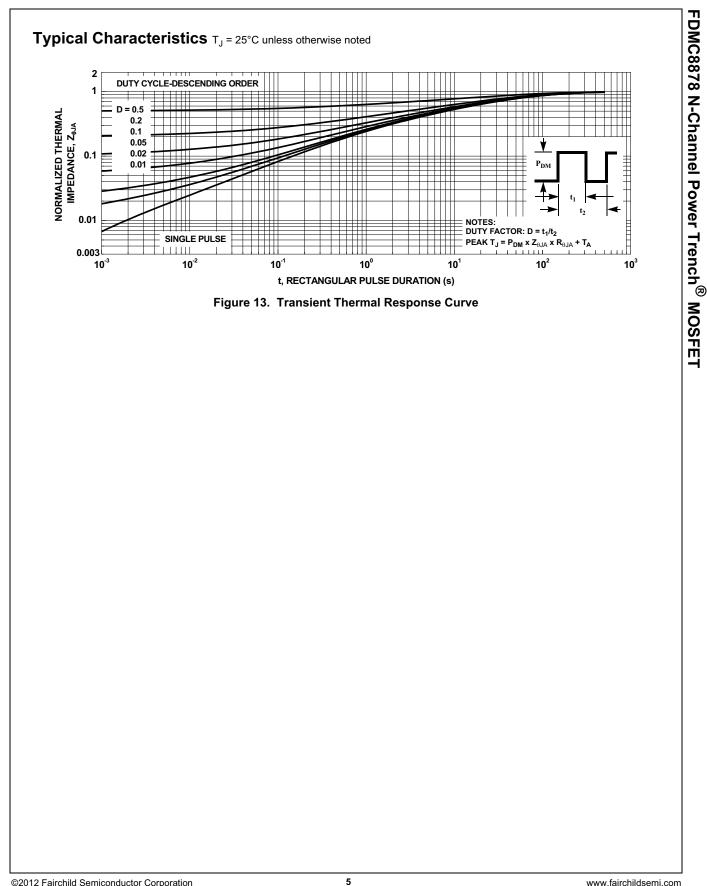
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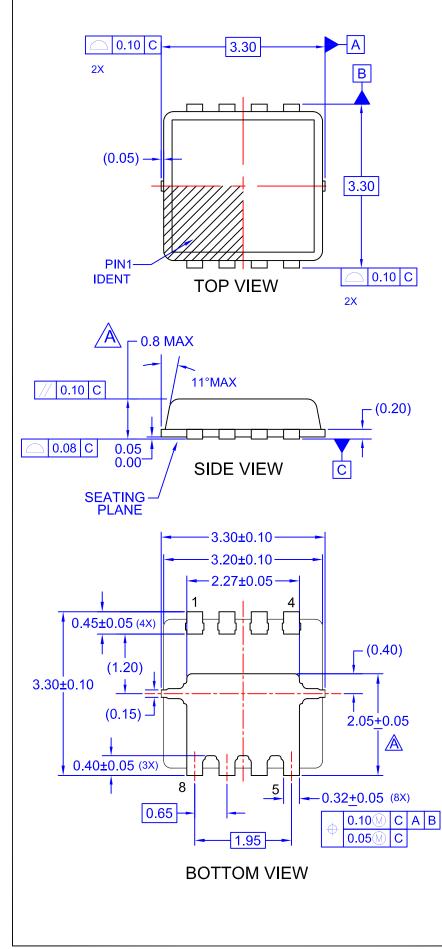


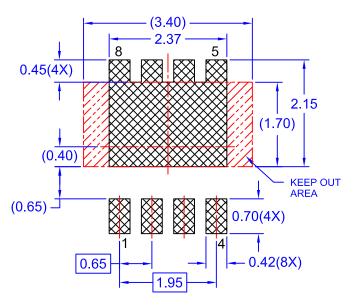
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FDMC8878 N-Channel Power Trench<sup>®</sup> MOSFET







### RECOMMENDED LAND PATTERN

**NOTES:** 

- A EXCEPT AS NOTED, PACKAGE CONFORMS TO JEDEC REGISTRATION MO-240 VARIATION BA.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. SEATING PLANE IS DEFINED BY TERMINAL TIPS ONLY
- E. BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS.
- F. FLANGE DIMENSIONS INCLUDE INTERTERMINAL FLASH OR PROTRUSION. INTERTERMINAL FLASH OR PROTRUSION SHALL NOT EXCEED 0.25MM PER SIDE.
- G. IT IS RECOMMENDED TO HAVE NO TRACES OR VIA WITHIN THE KEEP OUT AREA.
- H. DRAWING FILENAME: MKT-MLP08Trev4.
- I. GENERAL RADII FOR ALL CORNERS SHALL BE 0.20MM MAX.



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